

# Wavelet based detection of changes in the composition of RLC networks

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**Abstract.** The current work discusses the compositional analysis of spectra that may be related to amorphous materials that lack discernible Lorentzian, Debye or Drude responses. We propose to model such response using a 3-dimensional random RLC network using a descriptor formulation which is converted into an input-output transfer function representation. A wavelet identification study of these networks is performed to infer the composition of the networks. It was concluded that wavelet filter banks enable a parsimonious representation of the dynamics in excited randomly connected RLC networks. Furthermore, chemometric classification using the proposed technique enables the discrimination of dielectric samples with different composition. The methodology is promising for the classification of amorphous dielectrics.

## 1. Introduction

In broadband dielectric spectroscopy studies of amorphous materials that lack discernible Lorentzian, Debye or Drude responses, we tend to observe a Jonscher-like admittance response of fractional order as a function of frequency [1-17]. We propose to model such response using a 3-dimensional random RLC network, as depicted in Figure 1. Large networks of resistors, inductors and capacitors can be employed as lumped-parameter representations to model the response of composite materials containing conductive, resonant and insulating grains. For fixed  $R$ ,  $L$ ,  $C$  values, the network response in the time and frequency domains depends on the fraction of each component type. An incidence matrix analysis is used to model the network of branches with nodes consisting of resistive and capacitive elements distributed across several interconnected layers. The present paper is concerned with a screening problem in which deviations from a typical network composition are to be detected. In a real setting, such deviations may arise as the consequence of faults in the production process of a composite material, which should be promptly corrected to avoid the loss of additional batches.

## 2. Results from simulating 3-dimensional RLC networks

In the current study, wavelet identification of these networks is performed to infer the composition of the networks. The analysis is carried out in terms of a wavelet decomposition of the transient response to a standard excitation.

As can be seen in Figures 2 and 3, an increase in the fraction of resistors ( $f_R$ ) cannot be clearly detected from changes in the amplitude of the current waveforms  $i_s(t)$ .



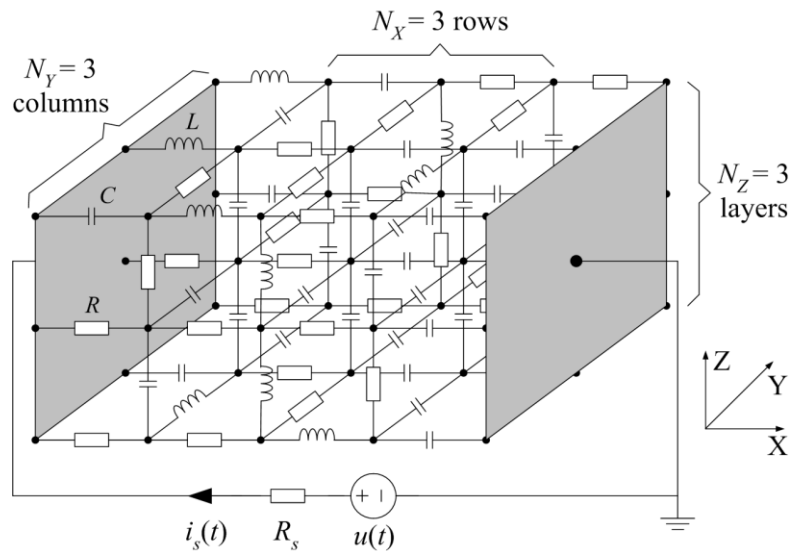


Fig. 1. Example of a 3-dimensional network with random allocation of  $R$ ,  $L$ ,  $C$  elements. The gray plates represent electrodes through which the network is connected to a nominal voltage source with resistance  $R_s$ .

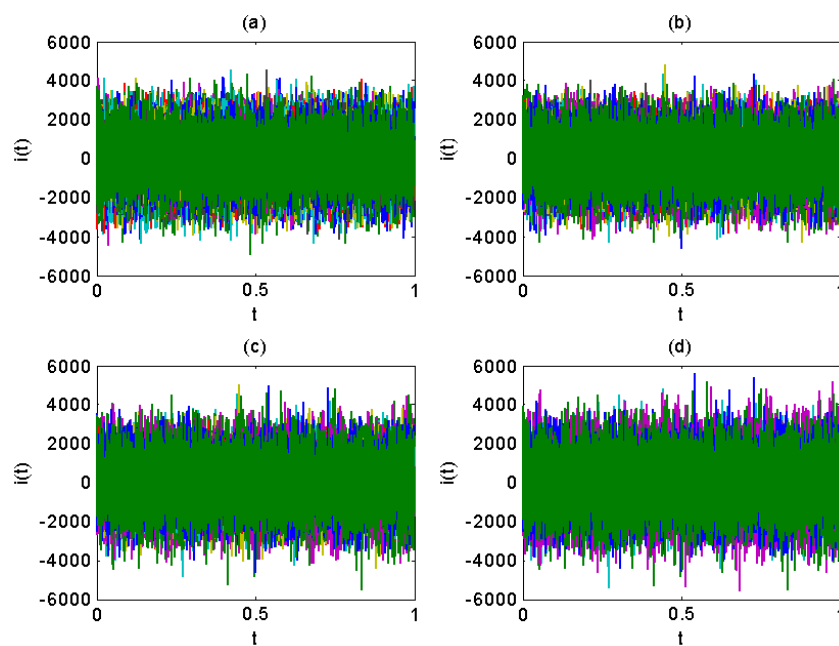


Fig. 2. Current waveforms obtained for 30 realizations of a 3-dimensional network with  $N_X = 5$ ,  $N_Y = 5$ ,  $N_Z = 6$  and  $R_s = 0.001$ ,  $R = 0.1$ ,  $C = 0.5$ ,  $L = 0.02$  (normalized units) by using a random voltage excitation (white noise). The network composition was set to  $f_R = 0.1$ ,  $f_C = 0.45$ ,  $f_L = 0.45$  in the nominal case (a). In the other cases, the resistor fraction was increased to  $f_R = 0.2$  (b),  $f_R = 0.3$  (c) and  $f_R = 0.4$  (d), while keeping  $f_C = f_L = (1 - f_R)/2$ . The sampling frequency was set to  $10^4$  (normalized unit).

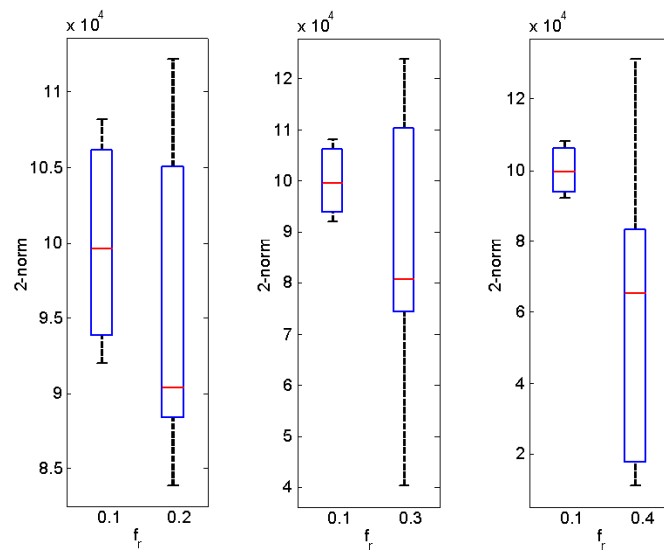


Fig. 3. Boxplots of the 2-norm of the current waveforms for the 30 network realizations. Each frame depicts the boxplot for the networks with nominal composition (left-hand side) and altered composition (right-hand side). On each box, the central red line corresponds to the median, the edges of the blue box indicate the 25<sup>th</sup> and 75<sup>th</sup> percentiles, and the black dotted segments extend to the most extreme data values which are not considered to be outliers.

However, by using the wavelet filter bank architecture depicted in Fig. 4 below, it is possible to obtain residues that change in a noticeable manner when  $f_R$  is increased as shown in Figures 5a-c.

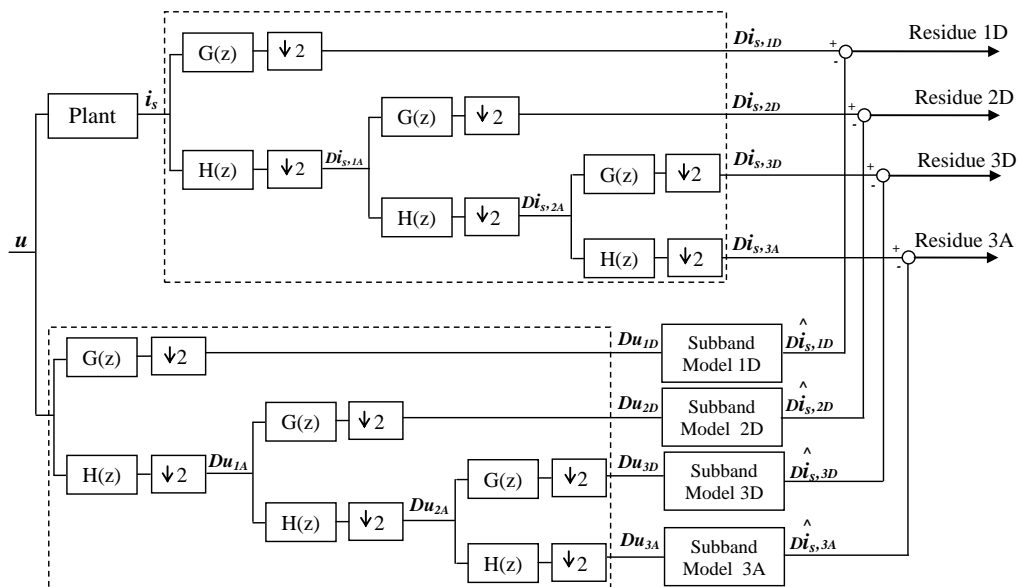


Fig. 4. Wavelet filter bank architecture employed in the generation of residues [18]. The db8 wavelet was employed in all calculations.

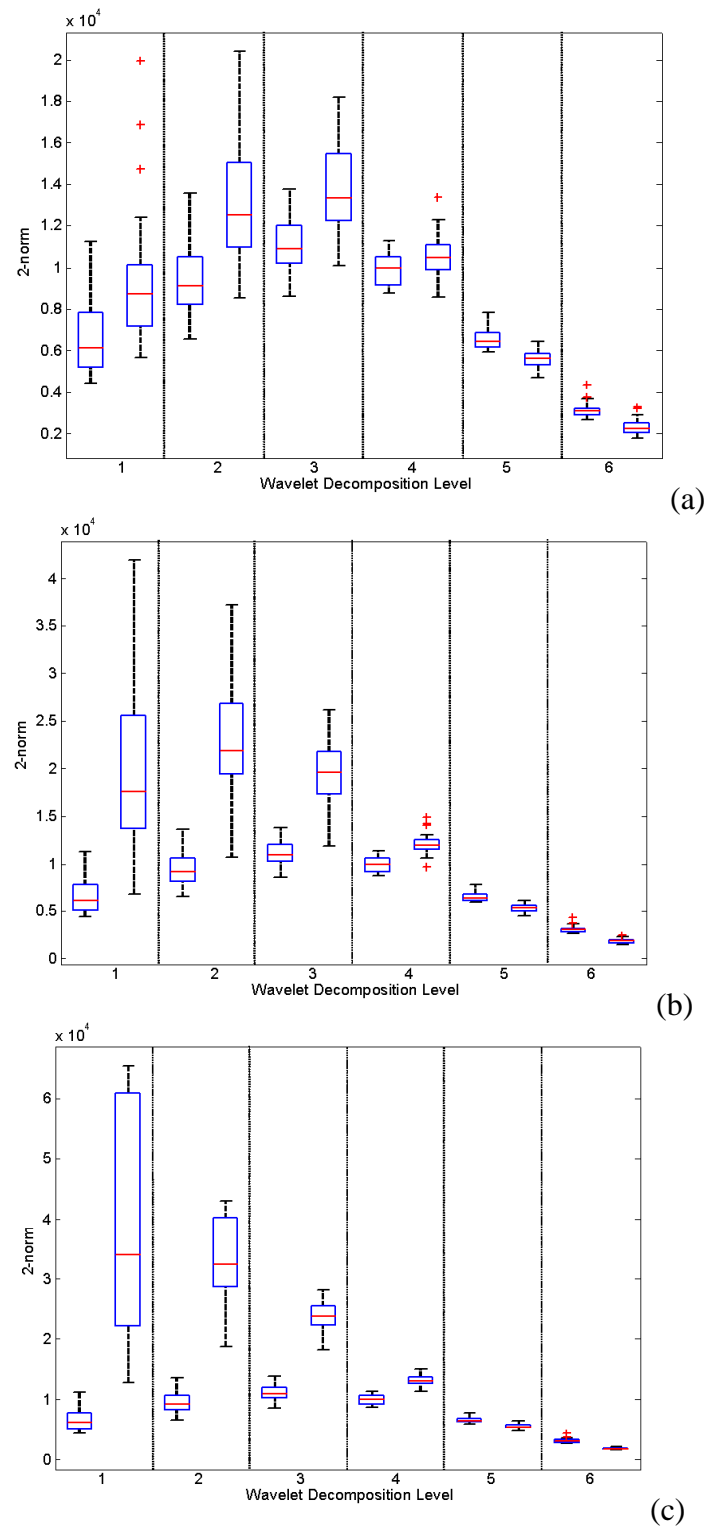


Fig. 5. Boxplots of the 2-norm of the sub-band residues for the 10 network realizations. Each frame corresponds to a fixed wavelet decomposition level, with a boxplot for the networks with nominal composition on the left-hand side and the networks with altered composition a) ( $f_R = 0.2$ ), b) ( $f_R = 0.3$ ) and c) ( $f_R = 0.4$ ) on the right-hand side. Outliers are indicated with red cross marks.

Wavelet filter banks have been extensively used in signal processing of time domain or frequency domain signals obtained in broadband spectroscopy studies [19-28], so the current application is a direct extension of these works providing an additional link between experimental studies and modelling using *RLC* networks. Further refinement of the technique may be possible by applying feature selection techniques, such as the successive projection algorithms [29-31], to the output of each sub-band of the wavelet models.

### 3. Conclusion

The results reveal that the proposed optimization procedure is indeed of value to improve sensitivity with respect to changes in the network composition. In a Chemometrics context, the reduced order models enable a simplified representation of the network dynamics, which can be used to infer the composition of the materials. This is of interest from a quality control perspective. The methodology is promising in classification of amorphous dielectrics.

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